

Notice of References Cited	Application/Control No. 10/667,157		Applicant(s)/Patent Under Reexamination KATAYAMA ET AL.	
	Examiner Tuan H. Nguyen		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,831,896	12-2004	Lempio et al.	370/252
	B	US-2003/0235179	12-2003	Tuomela et al.	370/347
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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